AMENDMENT Serial Number: 10/811,485

Filing Date: March 26, 2004

Title: Method And Apparatus For Forming A Nitride Layer On A Biomedical Device

Amendments to the Claims

This listing of claims will replace all prior versions and listings of claims in the subject

Page 3

SWRI:003

application.

Listing of Claims:

What is claimed is:

1. (Currently Amended) A method of forming a nitride layer on at least one metal or metal alloy

biomedical device, comprising: providing a vacuum chamber having a wall with at least one

biomedical device positioned thereon on a worktable within the vacuum chamber; reducing the

pressure in the vacuum chamber; introducing nitrogen into the vacuum chamber so that the

pressure in the vacuum chamber is about 0.01 to about 10 milli-Torr; generating electrons $\underline{\text{from a}}$

device comprising an electron source within the vacuum chamber to form positively charged

nitrogen ions; providing a voltage between said electron source and the vacuum chamber wall,

said voltage configured to draw electrons toward said chamber wall; providing a negative bias to

the worktable so that the positively charged nitrogen ions contact the biomedical devices under

conditions such that a nitride layer forms on the at least one prosthetic-biomedical device.

2. (Original) The method of claim 1, wherein the biomedical device is made of Ti-6Al-4V alloy,

Ti₆Al₇Nb, commercially pure titanium, or CoCrMo alloy.

3. (Original) The method of claim 1, wherein the bias of the worktable is maintained to provide a

temperature of about 700 and about 900 degrees Centigrade.

4. (Original) The method of claim 1, wherein the nitride layer has a thickness of at least about 1

micron.

5. (Original) The method of claim 1, wherein the worktable has a negative bias voltage of about

100 to about 2000 volts.

AMENDMENT Serial Number: 10/811,485 Filing Date: March 26, 2004

Title: Method And Apparatus For Forming A Nitride Layer On A Biomedical Device

6. (Original) The method of claim 1, wherein the electrons are generated using a filament.

7. (Original) The method of claim 1, wherein the vacuum chamber is reduced to a pressure of

less than 10^{-5} Torr prior to introduction of the nitrogen.

8. (Currently Amended) The method of claim 1, wherein nitrogen and an inert-another gas are

introduced into the vacuum chamber.

9. (Original) The method of claim 1, wherein the nitride layer has a thickness of about 1 to about

4 microns.

10. (Original) The method of claim 1, wherein the nitride layer has a thickness of about 3 to

about 4 microns.

11. (Original) The method of claim 1, wherein the nitrogen ions impact the biomedical devices

omnidirectionally.

12. (Original) The method of claim 1 wherein the temperature is at least about 300 degrees

Centigrade.

13. (Original) The method of claim 1, wherein the biomedical device contains titanium.

14. (Original) The method of claim 13, wherein the temperature is at least about 800 degrees

Centigrade.

15. (Original) The method of claim 1, wherein the biomedical device contains cobalt.

Page 5 SWRI:003

AMENDMENT Serial Number: 10/811,485

Filing Date: March 26, 2004

Title: Method And Apparatus For Forming A Nitride Layer On A Biomedical Device

16. (Original) The method of claim 1, wherein the temperature is at least about 650 to about 750

degrees Centigrade.

17. (Cancelled)

18. (Original) The method of claim 1, wherein the pressure is reduced to less than $10^6\,\mathrm{Torr}$ prior

to introduction of the nitrogen.

19. (Original) The method of claim 1, wherein the electrons are generated using a alternating

current power supply.

20. (Original) The method of claim 1, wherein the worktable is biased using a direct current

power supply.

21. (Withdrawn) An apparatus for forming a nitride layer of at least about 1 micron on a

biomedical device, comprising: a vacuum chamber, at least one source of electrons, at least one

nitrogen inlet, at least one worktable having a negative voltage bias, wherein the vacuum

chamber contains nitrogen at a pressure of about 0.01 to about 10 milli-Torr.

22. (Withdrawn) The apparatus of claim 21, wherein the source of electrons is a filament.

23. (Withdrawn) The apparatus of claim 21, wherein the negative voltage bias is about 100 to

about 2000 volts.

24. (Withdrawn) A biomedical device made of metal or metal alloy which comprises an outer

nitride layer having a thickness of at least 1 micron.

25. (Withdrawn) The device of claim 24, wherein the nitride layer is 3 to 4 microns thick.

Filing Date: March 26, 2004
Title: Method And Apparatus For Forming A Nitride Layer On A Biomedical Device

26. (Withdrawn) The device of claim 24, wherein the biomedical device is made of Ti-6Al-4V alloy, Ti₆Al₇Nb, commercially pure titanium, or CoCrMo alloy.

27. (New) The method of claim 1, wherein said voltage between said electron source and the vacuum chamber is in the range of 30 to 150 volts.